

HomeTek Technology Inc.

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CERTIFICATE OF COMPLIANCE

EUT : Programmable 8 input to 16 Output AV
Distributor

MODEL NO. : CD816XXX

Receipt Date : 05/15/2007 Final Test Date: 05/23/2007

REPORT # : EB6E025

APPLICANT : SMART CABLING & TRANSMISSION CORP.

ADDRESS : 10F, No. 493, Chung-Cheng Rd.,
Hsin Tien City, Taipei 231, Taiwan, R. O. C.

Measurement procedure used:

EMI: EN 55022 Class B (1998) + A1 (2000) + A2 (2003),

EN 61000-3-2 (2000), EN 61000-3-3 (1995) + A1 (2001)

EMS: EN 55024 (1998) + A1 (2001) + A2 (2003):

IEC 61000-4-2 (2001), IEC 61000-4-3 (2002), IEC 61000-4-4 (2004), IEC 61000-4-5 (2001),

IEC 61000-4-6 (2003) + A1 (2004), IEC 61000-4-8 (2001), IEC 61000-4-11 (2004)

We hereby show that:

The measurements shown in this test report were made in accordance with the procedures given in **EUROPEAN COUNCIL DIRECTIVE 2004/108/EC**, and the energy emitted by the equipment was found to be within the limits applicable.

This test result of this report applies to above tested sample only.

This test report shall not be reproduce in part without written approval of HomeTek Technology Inc.

APPROVED BY : 

ALAIN LIN / Supervisor



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APPENDIX A

PHOTOS OF TEST CONFIGURATION

APPENDIX B

PHOTOS OF EUT

GENERAL INFORMATION

- 1 APPLICANT : SMART CABLING & TRANSMISSION CORP.
- 2 ADDRESS : 10F, No. 493, Chung-Cheng Rd.,
Hsin Tien City, Taipei 231, Taiwan, R. O. C.
- 3 MANUFACTURER : SMART CABLING & TRANSMISSION CORP.
- 4 ADDRESS : 10F, No. 493, Chung-Cheng Rd.,
Hsin Tien City, Taipei 231, Taiwan, R. O. C.
- 5 DESCRIPTION OF EUT :
- EUT : Programmable 8 input to 16 Output AV
Distributor
- Model : CD816XXX
- Serial # : N/A

5.1 The difference between series of models CD816XXX are as shown below:

- (1) The first and second “X” represents different system input.
- (2) The third “X” represent different accessory.

The PCB layout is similar. The worst case of EMC test data were shown in this test report.

- 6 FEATURES OF EUT :

Please refer to user manual or product specification.



MODIFICATION LIST

THE FOLLOWING ACCESSORIES WERE ADDED TO THE EUT DURING TESTING :

NO MODIFICATION BY HOMETEK TECHNOLOGY INC.

CONDUCTED POWER LINE TEST

1 TEST INSTRUMENTS & FACILITIES

The following test Instruments was used during the conducted test :

Item	Instruments/ Facilities	Specification	Manufacturer	Model #	Date Of Cal.
1	EMI Receiver	9KHz ~ 30MHz	ROHDE & SCHWARZ	ESHS 30 844827/007	FEB/2007
2	LISN (for EUT)	50Ω/50uH/100A 150KHz ~ 30MHz	SCHWARZ BECK	NNLK 8121 8121370	OCT/2006
3	LISN (for Support Unit)	50Ω/50uH/10A 9KHz ~ 30MHz	ROHDE & SCHWARZ	ESH3-Z5 846128/007	MAR/2007
4	Terminator	50Ω	N/A	N/A	NOV/2006
5	Attenuation	50Ω/10dB	Mini-Circuit	NAT-10 AT-002	JUL/2006
6	Cable	5.4m	SUHNER	RG-223 CON2-002	AUG/2006
7	ESXS-K1 (software)	Version 2.03b 9KHz ~ 30MHz	ROHDE & SCHWARZ	1082.9678.02 840.913/246	N/A

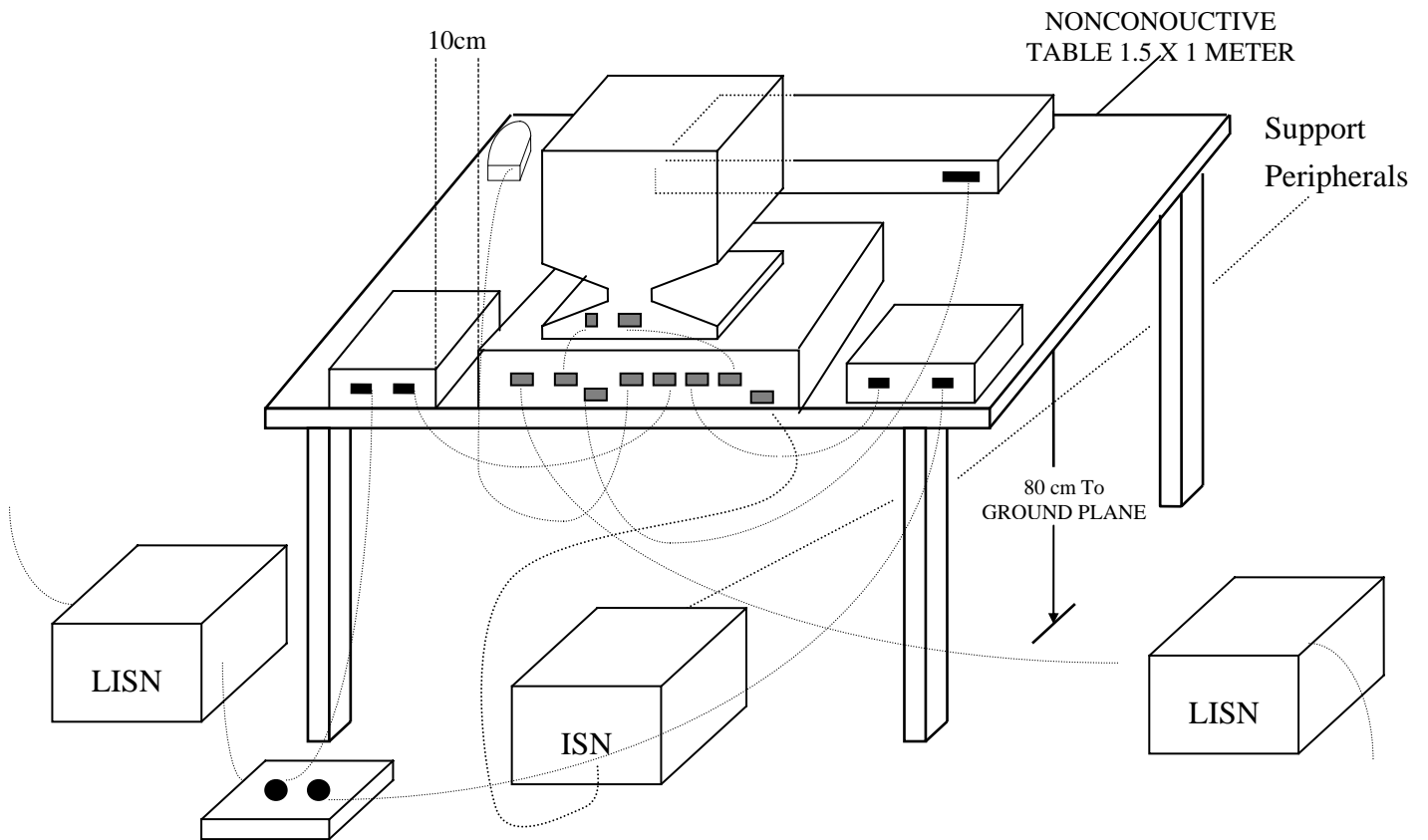
Note : Items 1 ~ 6 were calibrated within period of 1 year.

2 TEST PROCEDURE

- 2.1 The EUT was tested according to **EN55022 Class B**.
- 2.2 The EUT was placed 0.4 meter from the conducting wall of shielding room and kept at least 0.8 meter from any other grounded conducting surface.
- 2.3 The frequency range form 0.15 MHz to 30 MHz was investigated.
- 2.4 The LISN used was 50 Ohm / 50 uHenry as specified by **EN55022**.
- 2.5 All the support peripherals are connect to the other LISN.
- 2.6 Cables and peripherals were moved to find the maximum emission levels for each frequency.

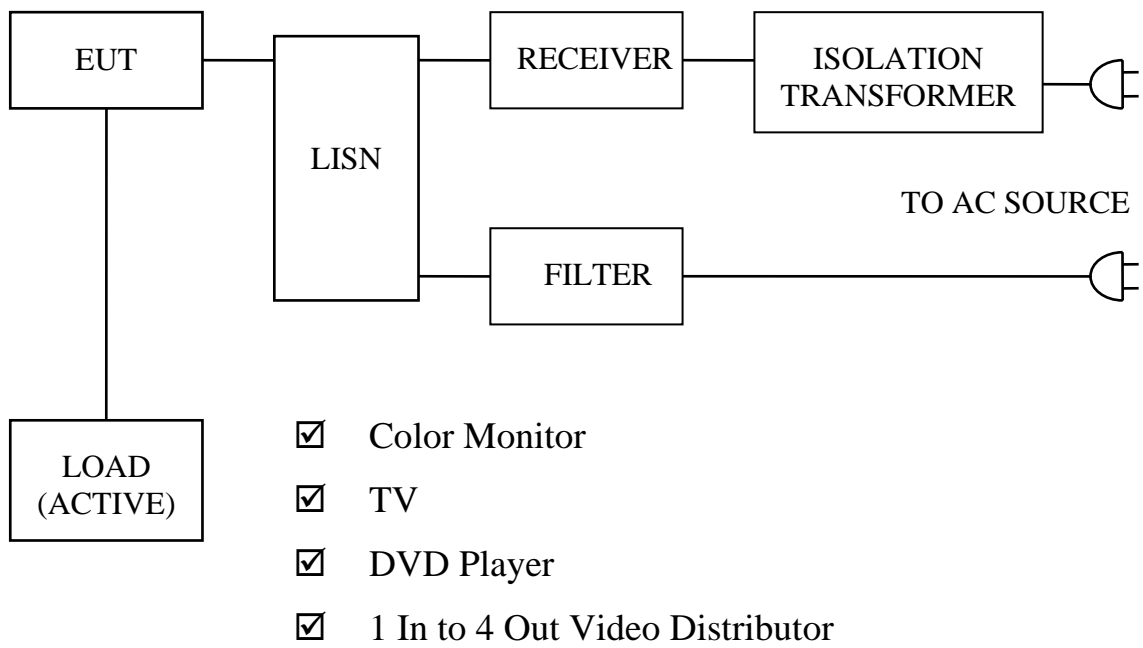
3 TEST SETUP

3.1 Typical : Setup Of Conducted Test



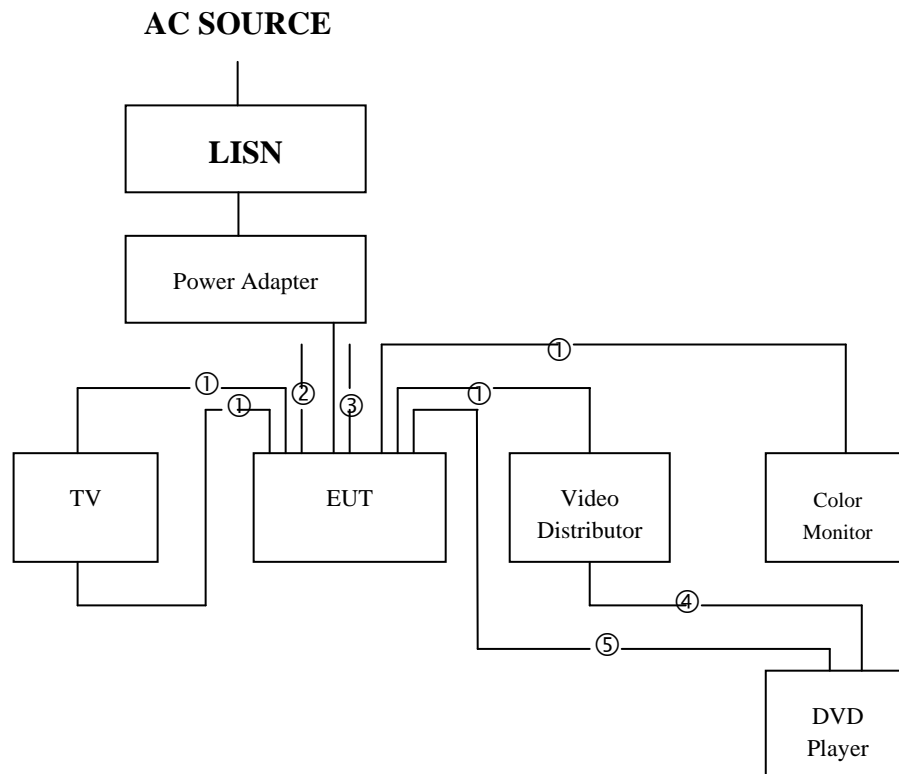
(Details for setup configuration, please refer to appendix A.)

3.2 Block Diagram Of Conducted Test



4 CONFIGURATION OF THE EUT

The EUT was configured according to **EN55022**. All I/O ports were connected to the appropriate peripherals. All peripherals and cables are listed below (including internal device) :



- ① AV Cable
- ② AV Input Cable Floating x 6
- ③ AV Output Cable Floating x 13
- ④ Video Cable
- ⑤ Audio Cable

Figure 1

4.1 EUT

EUT Type : Proto Type Engineer Type Mass Production
 Condition when received : Good Damage : _____
 Device : Programmable 8 input to 16 Output AV Distributor
 Applicant : SMART CABLING & TRANSMISSION CORP.
 Manufacturer : SMART CABLING & TRANSMISSION CORP.
 Model Number : CD816XXX
 Serial Number : N/A
 FCC ID : N/A
 AV Input Port x 2 : Metal Type Connector
 AV Output Port x 3 : Metal Type Connector
 AV Input Cable Floating x 6 : Shielded, 1.8 m, Metal Type Connector
 AV Output Cable Floating x 13 : Shielded, 1.8 m, Metal Type Connector
 Power Cord (AC) : 2 pin
 Power Cord (DC) : Un-Shielded, 1.8 m, 2 pin
 Power Supply Type : Linear Adapter

4.2 PERIPHERALS

Color Monitor
 Manufacturer : SAMPO
 Model Number : VM-C1486
 Serial Number : N/A
 FCC ID : N/A
 Data Cable : Shielded, 1.8 m, Connected to the Audio output port
 Power Cord : Un-Shielded, 2 m

DVD Player

Manufacturer : LG
Model Number : DS8421N
Serial Number : N/A
FCC ID : N/A
Data Cable : Shielded, 1.8 m, Connected to the AV input port
Power Cord & Adaptor : Un-Shielded, 1.8 m

 1 In to 4 Out Video Distributor

Manufacturer : SMART CABLING & TRANSMISSION CORP.
Model Number : 15-VD14
Serial Number : N/A
FCC ID : N/A
Data Cable : Shielded, 1.8 m, Connected to the Audio input port
Power Cord & Adaptor : Un-Shielded, 1.8 m

 TV

Manufacturer : TCL
Model Number : 1419A
Serial Number : 010019502035F0039
FCC ID : N/A
Data Cable : Shielded, 1.8 m, Connected to the Video output port
Power Cord : Un-Shielded



Power Adapter

Manufacturer : YUH AN
Model Number : ADP121000N-2
Serial Number : N/A
FCC ID : N/A
Data Cable : N/A
Power Cord (DC) : Un-Shielded, 1.8 m

4.3 REMARK : N/A

5 EUT OPERATING CONDITION

- 5.1 The frequency of the EUT is none.
- 5.2 Configure the EUT according to the **EN 55022 Class B**.
- 5.3 The test configuration included color monitor, TV, DVD Player and 1In to 4 Out video distributor.
- 5.4 Turn on all the power of EUT and peripheral.
- 5.5 During the test, DVD player sends color bar to the EUT through each input port individually.
- 5.6 TV and Color Monitor display color bar.
- 5.7 Measure the maximum emission noise.
- 5.8 **The photos of conducted test configuration, please refer to appendix A.**

6 LIMIT OF CONDUCTED POWER LINE EMISSION CLASS B

Frequency Range	Quasi Peak	Average
0.15 ~ 0.5 MHz	66 - 56 dBuV	56 - 46 dBuV
0.5 ~ 5 MHz	56 dBuV	46 dBuV
5 ~ 30 MHz	60 dBuV	50 dBuV

7 RESULT OF CONDUCTED POWER LINE TEST

- 7.1 The frequency range from 0.15 MHz to 30 MHz was investigated. All readings are quasi-peak values and average.
- 7.2 IF bandwidth : 9 kHz, Meas Time : 1 sec.
- 7.3 Temperature : 28 °C, Humidity : 50 % RH.
- 7.4 Deviations from the test standards and rules : None.
- 7.5 The conducted test result were gained by following procedures :
 Level = Reading Level + Insertion Loss of LISN + Cable Loss
 (All calculation were done by ESHS30 EMI test receiver.)
- 7.6 Result : **PASSED**

8 CONDUCTED POWER LINE TEST DATA (PAGE 1)

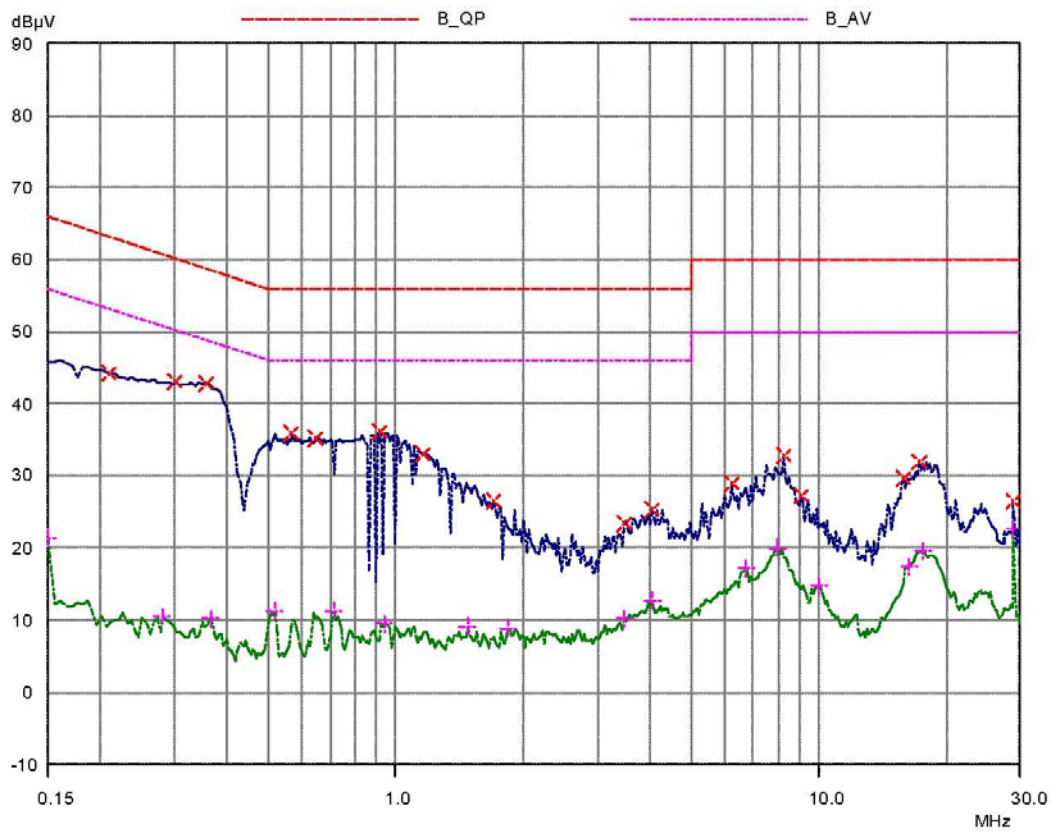
HomeTek EMC LAB. TEL :886-2-22608375

17 May 2007 20:20

CONDUCTED EMISSIONS

EUT: Programmable 8 input to 16 Output AV Distributor
 Manuf: 6E025
 Op Cond: LINE 1
 Operator: LIAO
 Test Spec: FOR EN55022 CLASS B
 Comment: 230V/50Hz
 CD816AVP
 Result File: 6e02511c.dat : CD816AVP 230V/50Hz L1

Prescan Measurement: Detectors: X PK / + AV
 Meas Time: see scan settings
 Subranges: 16
 Acc Margin: 55 dB





9 CONDUCTED POWER LINE TEST DATA (PAGE 2)

HomeTek EMC LAB. TEL :886-2-22608375

17 May 2007 20:20

CONDUCTED EMISSIONS

EUT: Programmable 8 input to 16 Output AV Distributor
 Manuf: 6E025
 Op Cond: LINE 1
 Operator: LIAO
 Test Spec: FOR EN55022 CLASS B
 Comment: 230V/50Hz
 CD816AVP
 Result File: 6e02511c.dat : CD816AVP 230V/50Hz L1

Prescan Measurement: Detectors: X PK / + AV
 Meas Time: see scan settings
 Subranges: 16
 Acc Margin: 55 dB

Peak Search Results

Frequency MHz	PK Level dBµV	PK Limit dBµV	PK Delta dB
0.21	44.26	63.21	18.95
0.3	42.99	60.24	17.25
0.355	42.83	58.84	16.01
0.565	35.79	56.00	20.21
0.65	35.17	56.00	20.83
0.92	36.14	56.00	19.86
1.16	32.91	56.00	23.09
1.7	26.47	56.00	29.53
3.44	23.34	56.00	32.66
4.0	25.38	56.00	30.62
6.23	28.85	60.00	31.15
8.27999	32.77	60.00	27.23
9.04	27.13	60.00	32.87
15.79	29.63	60.00	30.37
17.21	31.89	60.00	28.11
28.64	26.45	60.00	33.55

Frequency MHz	AV Level dBµV	AV Limit dBµV	AV Delta dB
0.15	21.35	56.00	34.65
0.28	10.50	50.82	40.32
0.365	10.17	48.61	38.44
0.515	11.33	46.00	34.67
0.71	11.31	46.00	34.69
0.94	9.53	46.00	36.47
1.48	9.13	46.00	36.87
1.83	8.91	46.00	37.09
3.44	10.21	46.00	35.79
4.0	12.72	46.00	33.28
6.67	17.12	50.00	32.88
7.93	19.94	50.00	30.06
9.97	14.80	50.00	35.20
16.26	17.44	50.00	32.56
17.53	19.54	50.00	30.46
28.64	22.67	50.00	27.33

* limit exceeded

10 CONDUCTED POWER LINE TEST DATA (PAGE 3)

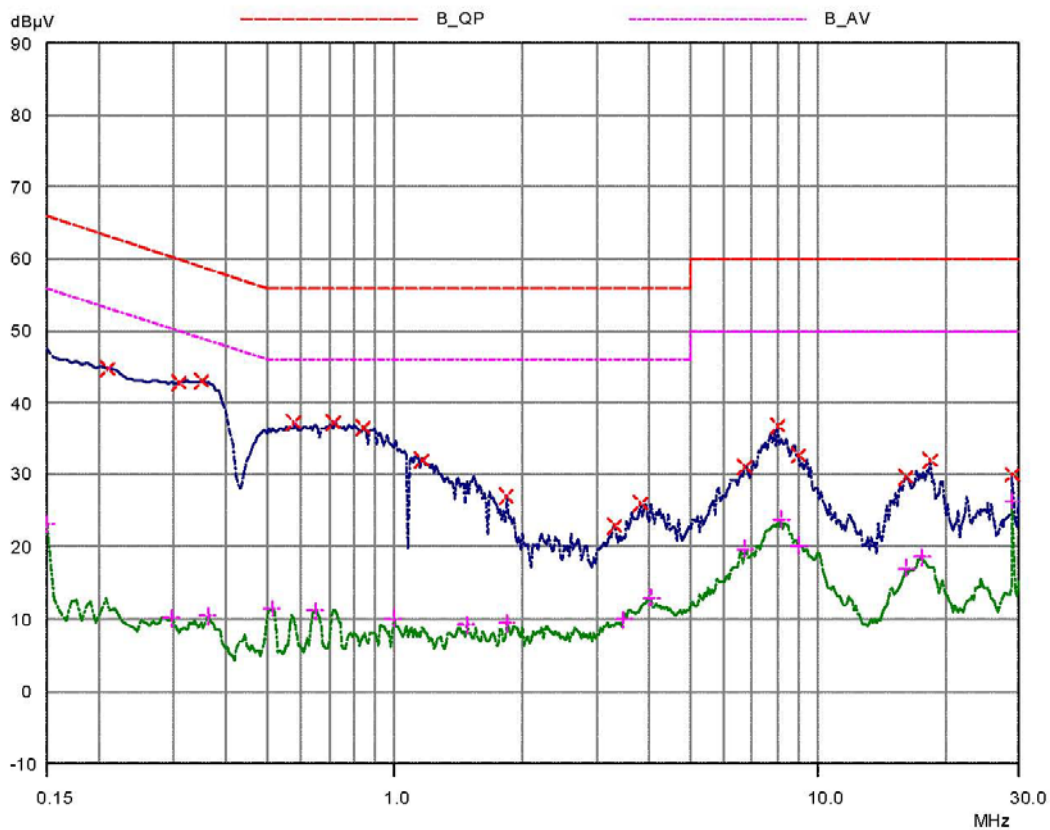
HomeTek EMC LAB. TEL :886-2-22608375

17 May 2007 20:24

CONDUCTED EMISSIONS

EUT: Programmable 8 input to 16 Output AV Distributor
 Manuf: 6E025
 Op Cond: LINE 2
 Operator: LIAO
 Test Spec: FOR EN55022 CLASS B
 Comment: 230V/50Hz
 CD816AVP
 Result File: 6e02521c.dat : CD816AVP 230V/50Hz L2

Prescan Measurement: Detectors: X PK / + AV
 Meas Time: see scan settings
 Subranges: 16
 Acc Margin: 55 dB





11 CONDUCTED POWER LINE TEST DATA (PAGE 4)

HomeTek EMC LAB. TEL :886-2-22608375

17 May 2007 20:24

CONDUCTED EMISSIONS

EUT: Programmable 8 input to 16 Output AV Distributor
 Manuf: 6E025
 Op Cond: LINE 2
 Operator: LIAO
 Test Spec: FOR EN55022 CLASS B
 Comment: 230V/50Hz
 CD816AVP
 Result File: 6e02521c.dat : CD816AVP 230V/50Hz L2

Prescan Measurement: Detectors: X PK / + AV
 Meas Time: see scan settings
 Subranges: 16
 Acc Margin: 55 dB

Peak Search Results

Frequency MHz	PK Level dBµV	PK Limit dBµV	PK Delta dB
0.21	44.82	63.21	18.39
0.31	42.86	59.97	17.11
0.35	43.10	58.96	15.86
0.575	37.26	56.00	18.74
0.72	37.39	56.00	18.61
0.84	36.66	56.00	19.34
1.16	32.06	56.00	23.94
1.84	26.98	56.00	29.02
3.3	22.90	56.00	33.10
3.78	26.05	56.00	29.95
6.67	31.09	60.00	28.91
8.02	36.72	60.00	23.28
8.99	32.63	60.00	27.37
16.12	29.71	60.00	30.29
18.51	32.11	60.00	27.89
28.64	29.96	60.00	30.04

Frequency MHz	AV Level dBµV	AV Limit dBµV	AV Delta dB
0.15	23.12	56.00	32.88
0.295	10.14	50.38	40.24
0.36	10.44	48.73	38.29
0.51	11.46	46.00	34.54
0.645	11.20	46.00	34.80
0.99	10.12	46.00	35.88
1.48	9.22	46.00	36.78
1.84	9.49	46.00	36.51
3.44	9.97	46.00	36.03
4.0	12.97	46.00	33.03
6.67	19.69	50.00	30.31
8.15	23.82	50.00	26.18
8.97	20.21	50.00	29.79
16.07999	17.07	50.00	32.93
17.52	18.55	50.00	31.45
28.64	26.36	50.00	23.64

* limit exceeded

RADIATED EMISSION TEST

1 TEST INSTRUMENTS & FACILITIES

The following test Instruments was used during the radiated emission test :

Item	Instruments /facilities	Specification	Manufacturer	Model # / S/N#	Date of Cal.
1	OPEN AREA TEST SITE	<input checked="" type="checkbox"/> OATS 3			JUL/2006
2	EMI TEST RECEIVER	20Hz ~ 26.5GHz	ROHDE & SCHWARZ	ESMI 845442/006	FEB/2007
3	PRE-AMPLIFIER	9KHz ~ 3000MHz	ADVANTEST	BB525C 90081001	OCT/2006
4	ANTENNA (BI-LOG)	25MHz ~ 2GHz	SCHAFFNER	CBL6112B S/N : 2614	JUN/2006
5	Attenuation	50Ω/6dB	JYE BAO	FAT-N (M-F) 001	JUL/2006
6	Ferrite Clamp	30 ~ 1000MHz	ADT	FC18 910030	DEC/2006
7	Ferrite Clamp	30 ~ 1000MHz	HomeTek	HFC 001	DEC/2006
8	Cable	10m	SUHNER	RG214/U OS3-003	DEC/2006
9	Cable	14m	BELDEN	9913 OS3-001	DEC/2006
10	EMI 32 (software)	N/A	AUDIX	19991013-0923	N/A

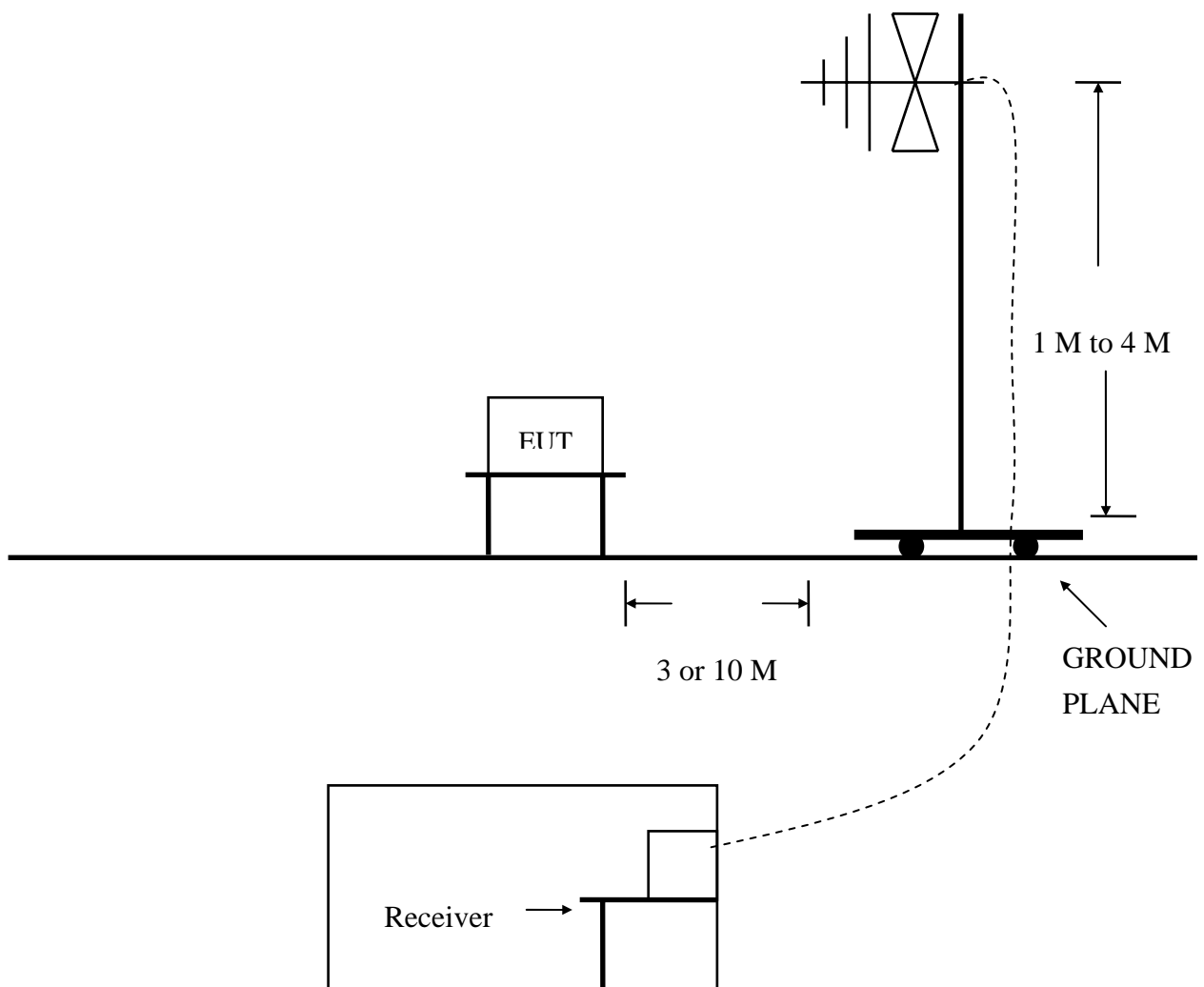
Note : Items 1 ~ 9 were calibrated within period of 1 year.

2 TEST PROCEDURE

- 2.1 The EUT was test according to **EN55022**.
- 2.2 The radiated test was performed at HomeTek Lab's Open Site III.
- 2.3 The frequency range from 30 MHz to 1 GHz, the measurement were made at 10 meters, with a BI-log antenna.

3 TEST SETUP

3.1 TEST SETUP OF OPEN SITE.



(Details for setup configuration, please refer to appendix A.)

4 CONFIGURATION OF THE EUT

Same as “Conducted Power Line test”, section 4

5 EUT OPERATING CONDITION

5.1 Same as “Conducted Power Line test”, section 5

5.2 The radiated emission in the frequency range from 30 MHz - 1000 MHz was test in a horizontal and vertical polarization at HomeTek Lab’s open site III.

5.3 The photos of radiated test configuration, please refer to appendix A.

6 LIMIT OF RADIATED EMISSION CLASS B

Frequency (MHz)	Measurement Distance	Limit (dBuV/m)
30 - 230	10 (M)	30
230 - 1000	10 (M)	37

7 RESULT OF RADIATED EMISSION TEST

7.1 The frequency range from 30 MHz to 1 GHz was investigated.

7.2 All readings below or equal 1 GHz are quasi-peak or peak values with resolution bandwidth of 120 KHz.

7.3 The measurements were made at 10 meters of HomeTek Lab’s open site III.

7.4 Temperature : 29 °C, Humidity : 58 % RH.

7.5 Deviation form the test standards and rules : None.

7.6 The radiated emission result were gained by the following method :

Level = Reading Level + Probe Factor (Antenna Factor) + Cable Loss – Preamp Factor

Over Limit = Level – Limit Line

7.7 Result : **PASSED**

8 RADIATED EMISSION TEST DATA (PAGE 1)

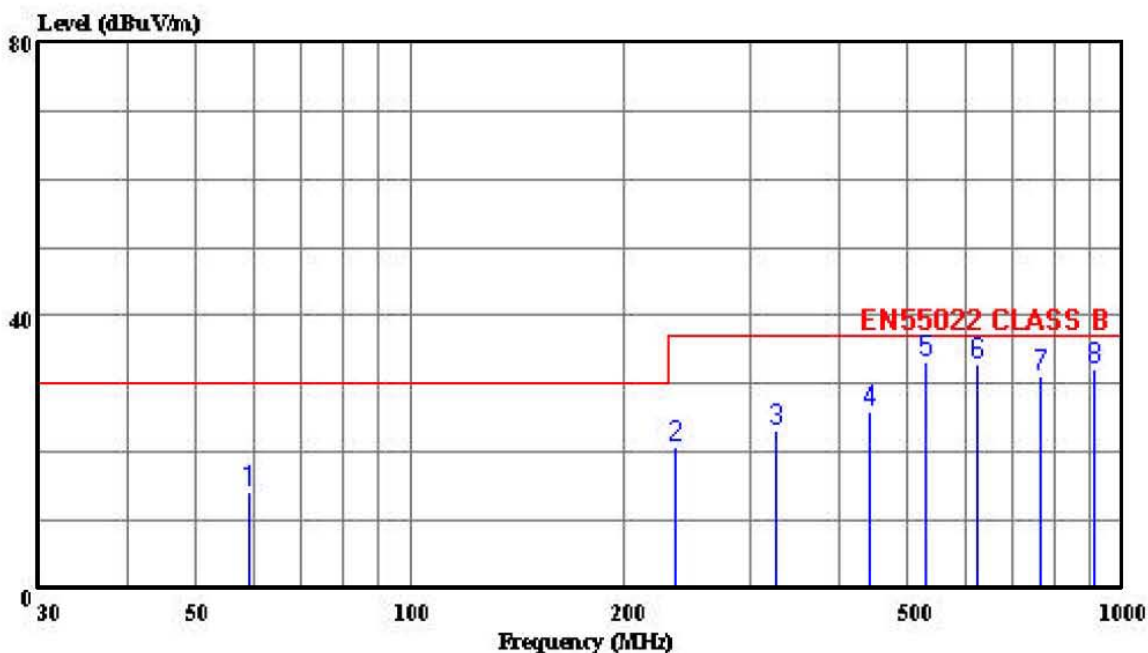


HomeTek Technology Inc.

No 67-9, Shi-Men Rd., Tu-Chen City,
 Taipei County, Taiwan R.O.C.
 Tel: 02-22608375
 Fax: 02-22748013

Data#: 3 File#: 6e025.emi

Date: 2007-05-22 Time: 17:09:18



Trace:

Ref Trace:

Condition: EN55022 CLASS B 10m CHASE 2614 060506 HORIZONTAL
 eut : Programmable 8 input to 16 Output AV
 power: 230V/50Hz
 memo : CD816AVP

Page: 1

	Freq	Level	Limit	Over	ReadAntenna	Cable	Preamp	Remark
	MHz	dBuV/m	dBuV/m	dB	Level	Loss	Factor	
					Factor			
					dB/m	dB	dB	
1	59.163	14.24	30.00	-15.76	32.22	7.05	0.93	25.96 Peak
2	235.513	20.68	37.00	-16.32	33.00	10.94	2.38	25.63 Peak
3	326.205	23.35	37.00	-13.65	32.00	13.83	2.94	25.42 Peak
4	442.945	26.06	37.00	-10.94	31.02	16.48	3.60	25.04 Peak
5	531.163	33.12	37.00	-3.88	35.00	18.23	4.60	24.71 Peak
6	625.015	32.86	37.00	-4.14	32.78	18.75	5.68	24.36 Peak
7	767.015	31.20	37.00	-5.80	30.27	19.70	5.10	23.87 Peak
8	909.992	32.24	37.00	-4.76	30.00	20.46	5.20	23.42 Peak

9 RADIATED EMISSION TEST DATA (PAGE 2)

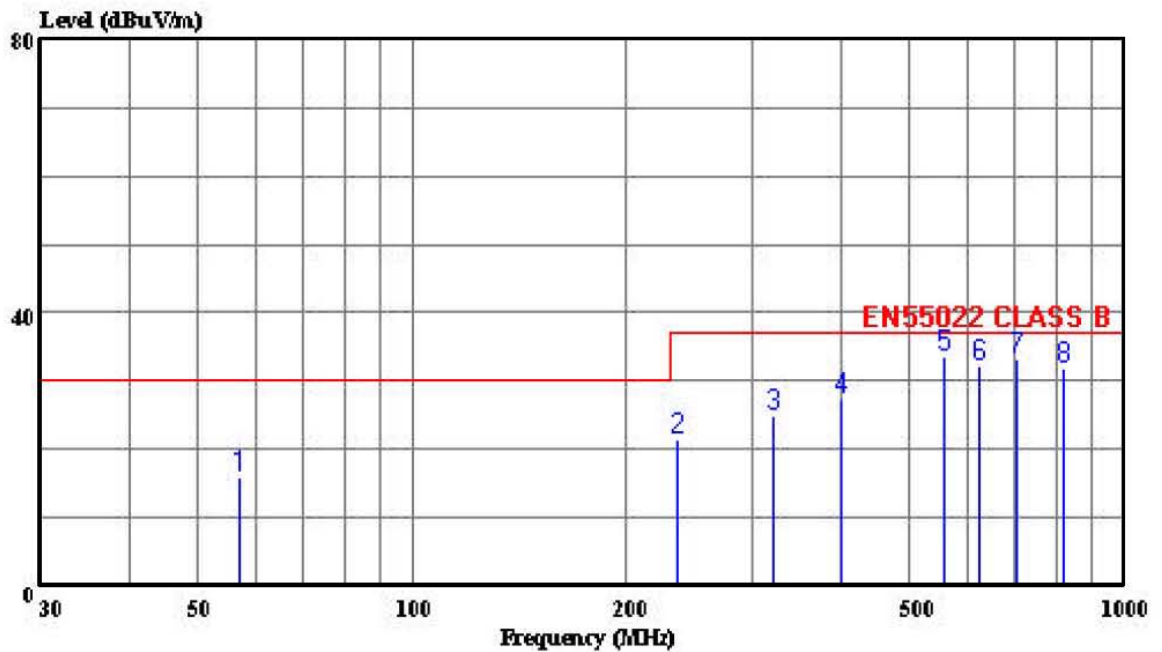


HomeTek Technology Inc.

No 67-9, Shi-Men Rd., Tu-Chen City,
 Taipei County, Taiwan R.O.C.
 Tel: 02-22608375
 Fax: 02-22748013

Data#: 4 File#: 6e025.emi

Date: 2007-05-22 Time: 17:34:17



Trace:

Ref Trace:

Condition: EN55022 CLASS B 10m CHASE 2614 060506 VERTICAL
 eut : Programmable 8 input to 16 Output AV
 power: 230V/50Hz
 memo : CD816AVP

Page: 1

	Freq	Level	Limit	Over	ReadAntenna	Cable	Preamp	Remark
	MHz	dBuV/m	dBuV/m	dB	dBuV	dB/m	dB	dB
1	57.033	16.05	30.00	-13.95	33.72	7.40	0.89	25.96 Peak
2	234.753	21.60	37.00	-15.40	34.00	10.86	2.37	25.64 Peak
3	320.040	25.10	37.00	-11.90	34.00	13.65	2.90	25.44 Peak
4	400.953	27.53	37.00	-9.47	33.79	15.60	3.35	25.21 Peak
5	556.853	33.62	37.00	-3.38	34.50	18.68	5.06	24.62 Peak
6	625.043	32.13	37.00	-4.87	32.05	18.75	5.68	24.36 Peak
7	704.853	33.25	37.00	-3.75	33.27	18.87	5.13	24.02 Peak
8	824.222	31.72	37.00	-5.28	30.30	19.99	5.13	23.69 Peak

HARMONICS TEST

1 TEST INSTRUMENTS & FACILITIES

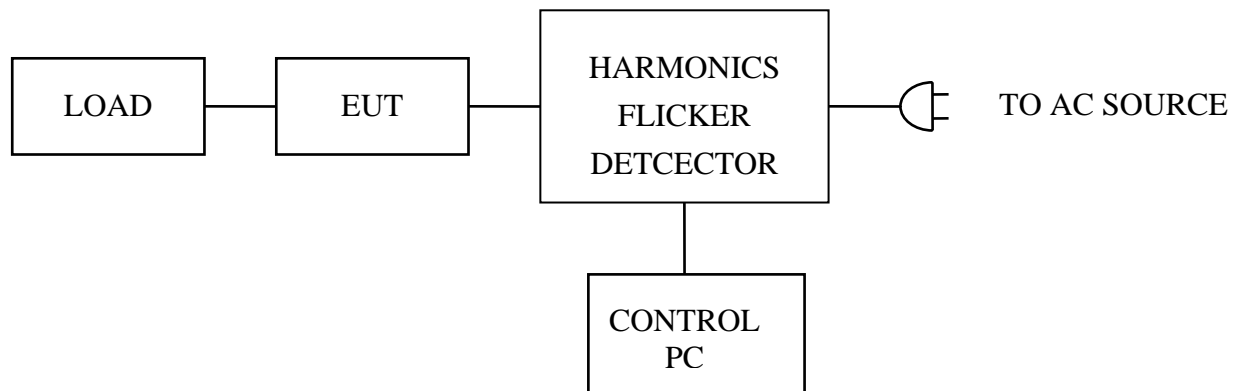
Instruments/ facilities	Manufacturer	Model # Serial #	Date of Cal.
HARMONICS/ VOLTAGE FLUCTUATIONS TEST	EMC-PARTNER	HAR1000-1P	NOV/2006
CONTROL PC	KB TECH	KB P586/133	N/A

Note : Item 1 were calibrated with two years and verified before testing.

2 TEST PROCEDURE

According to EN 61000-3-2 (2000) Class A

3 TEST SETUP



(Details for setup configuration, please refer to appendix A.)

4 CONFIGURATION OF THE EUT

Same as “Conducted Power Line test”, section 4

5 OPERATION CONDITION OF EUT

Same as “Conducted Power Line test”, section 5

6 TEST DATA & LIMIT

6.1 Temperature : 28 °C

6.2 Humidity : 55 % RH

7 Photos of test configuration please refer to appendix A.



8 HARMONICS TEST DATA (PAGE 1~2)

EMC PARTNER AG, SWITZERLAND

Date : 2007/5/21 PM 05:49:0 V4.14

Operator : JASON
 Unit : Programmable 8 input to 16 Output AV Distributor
 Serialnumber : CD816AVP
 Remarks : 6E025

Urms = 230.1V Freq = 50.000 Range: 0.25 A
 Irms = 0.082A Ipk = 0.139A cf = 1.704
 P = 12.23W S = 18.79VA pf = 0.651
 THDi = 44.2 % THDu = 0.10 % Class A

Test - Time : 15min (100 %)

Test completed, Result: PASSED

Order	Freq. [Hz]	I _{max} [A]	I _{max} %L [%]	Limit [A]	Status
1	50	0.2418			
2	100	0.0009	0.0819	1.0800	
3	150	0.0287	1.2479	2.3000	
4	200	0.0005	0.1065	0.4300	
5	250	0.0225	1.9703	1.1400	
6	300	0.0002	0.0712	0.3000	
7	350	0.0017	0.2160	0.7700	
8	400	0.0001	0.0464	0.2300	
9	450	0.0019	0.4807	0.4000	
10	500	0.0000	0.0166	0.1840	
11	550	0.0027	0.8277	0.3300	
12	600	0.0000	0.0000	0.1533	
13	650	0.0008	0.3851	0.2100	
14	700	0.0000	0.0116	0.1314	
15	750	0.0009	0.6205	0.1500	
16	800	0.0000	0.0000	0.1150	
17	850	0.0008	0.6226	0.1324	
18	900	0.0000	0.0000	0.1022	
19	950	0.0004	0.3737	0.1184	
20	10000	0.0000	0.0000	0.0920	
21	10500	0.0005	0.4415	0.1071	
22	11000	0.0000	0.0000	0.0836	
23	11500	0.0003	0.3432	0.0978	
24	12000	0.0000	0.0000	0.0767	
25	12500	0.0003	0.3391	0.0900	



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26	13000.0000	0.0000	0.0708
27	13500.0002	0.2930	0.0833
28	14000.0000	0.0000	0.0657
29	14500.0002	0.2753	0.0776
30	15000.0000	0.0000	0.0613
31	15500.0002	0.2733	0.0726
32	16000.0000	0.0000	0.0575
33	16500.0002	0.2238	0.0682
34	17000.0000	0.0000	0.0541
35	17500.0002	0.2374	0.0643
36	18000.0000	0.0000	0.0511
37	18500.0001	0.2007	0.0608
38	19000.0000	0.0000	0.0484
39	19500.0001	0.2116	0.0577
40	20000.0000	0.0000	0.0460

Important:

- without "1000-4-7 Ed. 2" (DFT-window is 16 periods)

VOLTAGE FLUCTUATIONS TEST

1 TEST INSTRUMENTS & FACILITIES

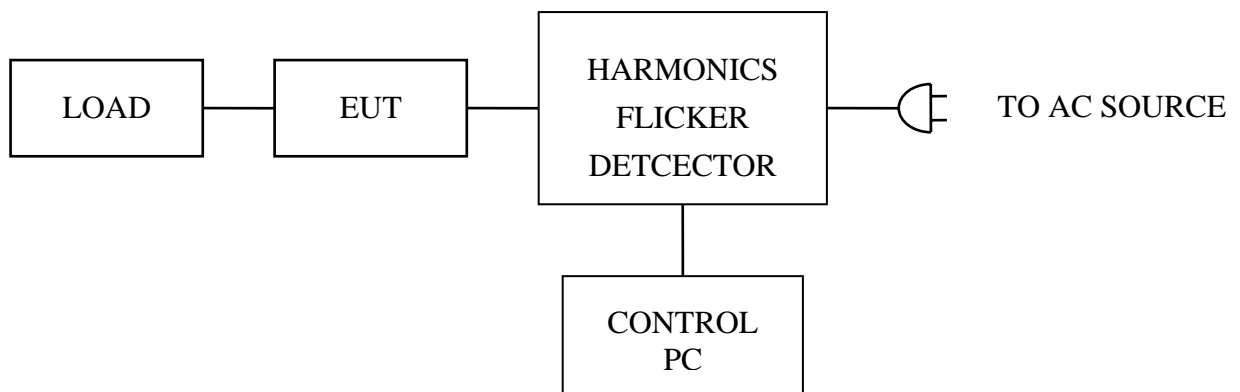
Instruments/ facilities	Manufacturer	Model # Serial #	Date of Cal.
HARMONICS/ VOLTAGE FLUCTUATIONS TEST	EMC-PARTNER	HAR1000-1P	NOV/2006
CONTROL PC	KB TECH	KB P586/133	N/A

Note : Item 1 were calibrated with two years and verified before testing.

2 TEST PROCEDURE

According to **EN 61000-3-3 (1995) + A1 (2001)**

3 TEST SETUP



(Details for setup configuration, please refer to appendix A.)

4 CONFIGURATION OF THE EUT

Same as “Conducted Power Line test”, section 4

5 OPERATION CONDITION OF EUT

Same as “Conducted Power Line test”, section 5

6 TEST DATA & LIMIT

6.1 Temperature : 28 °C

6.2 Humidity : 55 % RH

7 Photos of test configuration please refer to appendix A.



8 VOLTAGE FLUCTUATIONS TEST DATA (PAGE 1)

EMC PARTNER AG, SWITZERLAND

Date : 2007/5/21 PM 06:17:4 V4.14

Operator : JASON
 Unit : Programmable 8 input to 16 Output AV Distributor
 Serialnumber : CD816AVP
 Remarks : 6E025

Urms = 229.9V Freq = 49.987 Range: 0.25 A
 Irms = 0.084A Ipk = 0.146A cf = 1.733
 P = 13.02W S = 19.31VA pf = 0.674

Test - Time : 1 x 15min = 15min (100 %)

LIN (Line Impedance Network) : L: 0.24ohm +j0.15ohm N: 0.16ohm +j0.10ohm

Limits :Plt : 0.65Pst : 1.00
 dmax : 4.00 % dc : 3.30 %
 dtLim: 3.30 % dt>Lim: 500ms

Test completed, Result: PASSED

Plt = 0.072

Pst dmax
 [%]

1 0.072 0.000

ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

1 TEST INSTRUMENTS & FACILITIES

Instruments/ Facilities	Manufacturer	Model # Serial #	Data Of Cal.
ESD TESTER	HAEFELY	PESD 1610	NOV/2006
VCP	HOMETEK	--	--

2 TEST PROCEDURE

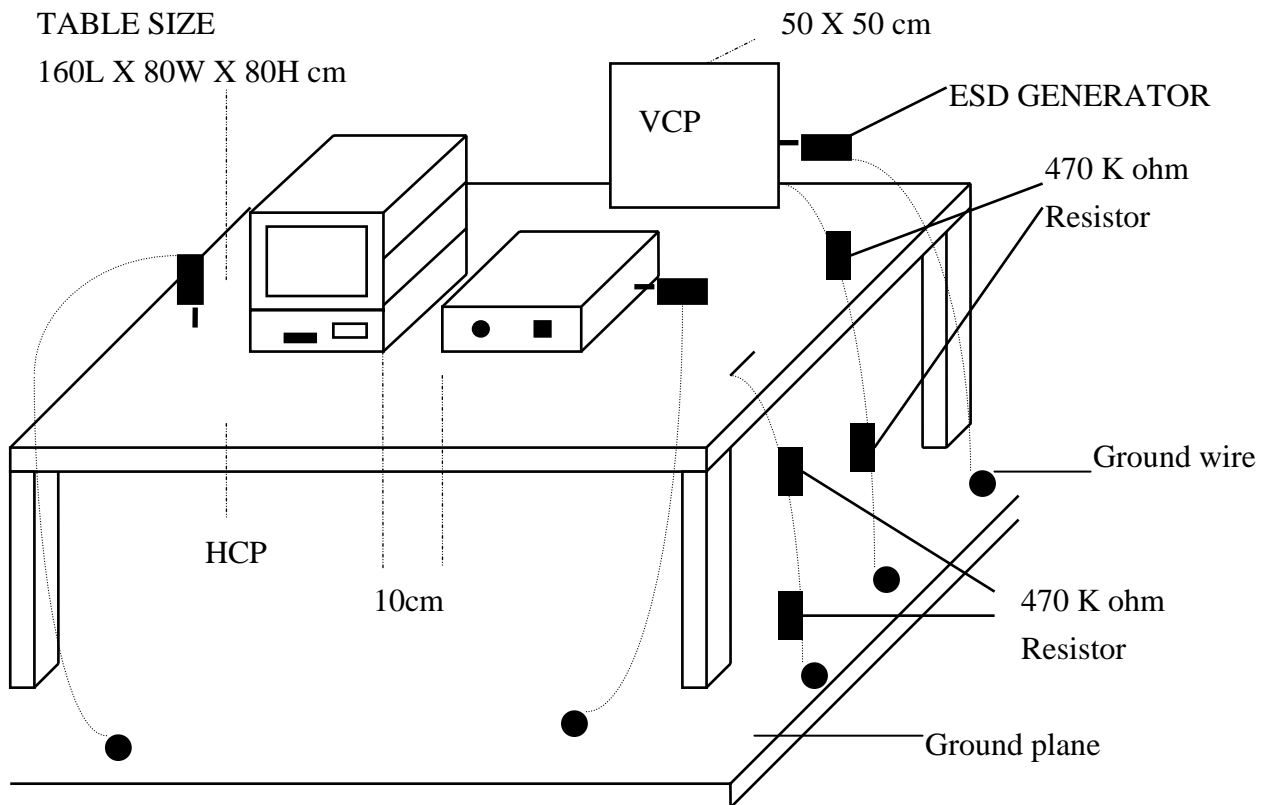
According to **IEC 61000-4-2 (2001)**

According to **EN 55024 (1998) + A1 (2001) + A2 (2003)**

3 TEST SETUP

TABLE SIZE

160L X 80W X 80H cm



(Details for setup configuration, please refer to appendix A.)

4 CONFIGURATION OF THE EUT

Same as “Conducted Power Line test”, section 4

5 EUT OPERATION CONDITION

Same as “Conducted Power Line test”, section 5

6 TEST CONDITION

6.1 Test Level :

(A) $\pm 2, 4, 8$ KV for air discharge.

(B) $\pm 2, 4$ KV for contact discharge.

6.2 Number of test : 10 Discharges / Test point / Polarity / Level

Particular requirements : at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points.

6.3 Time between test : 1 sec.

6.4 Temperature : 27 °C

6.5 Humidity : 50 % RH.

7 PERFORMANCE CRITERIA

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

8 TEST RESULT

Test Point	Air Discharge	Contact Discharge	Performance Criteria	Result
HCP	---	±2, 4KV	B	PASSED
VCP	---	±2, 4KV	B	PASSED
CASE	±2, 4, 8KV	±2, 4KV	B	PASSED
I/O PORTS	±2, 4, 8KV	±2, 4KV	B	PASSED
SCREWS	±2, 4, 8KV	±2, 4KV	B	PASSED
BUTTON	±2, 4, 8KV	±2, 4KV	B	PASSED
DC SOCKET	±2, 4, 8KV	±2, 4KV	B	PASSED

※ The screen was flash during the test. After the test, EUT resume automatically.

9 Photos of test configuration please refer to appendix A.

RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

1 TEST INSTRUMENTS & FACILITIES

Item	Instruments Facilities	Manufacturer	Model # Serial #	Data Of Cal.
1	SIGNAL GENERATOR	ROHDE & SCHWARZ	SMY02 845181/025	MAR/2007
2	AMPLIFIER	AMPLIFIER RESEARCH	100W1000M1A	N/A
3	FIELD SENSOR	AMPLIFIER RESEARCH	FP2000	AUG/2006
4	FIELD MONITOR	AMPLIFIER RESEARCH	FM2000	AUG/2006
5	RF VOLTMETER	BOONTON	9200C 361701AA	MAR/2007
6	RF PROBE	BOONTON	952001B 37082	MAR/2007
7	DIRECTION COUPLER	AMPLIFIER RESEARCH	DC6180 20521	N/A
8	ANTENNA	EMCO	3142B S/N: 1789	N/A
9	CONTROL PC	KB TECH	KB P586/133	--

Note : Items 3 ~ 4 were calibrated with two years and verified before testing.

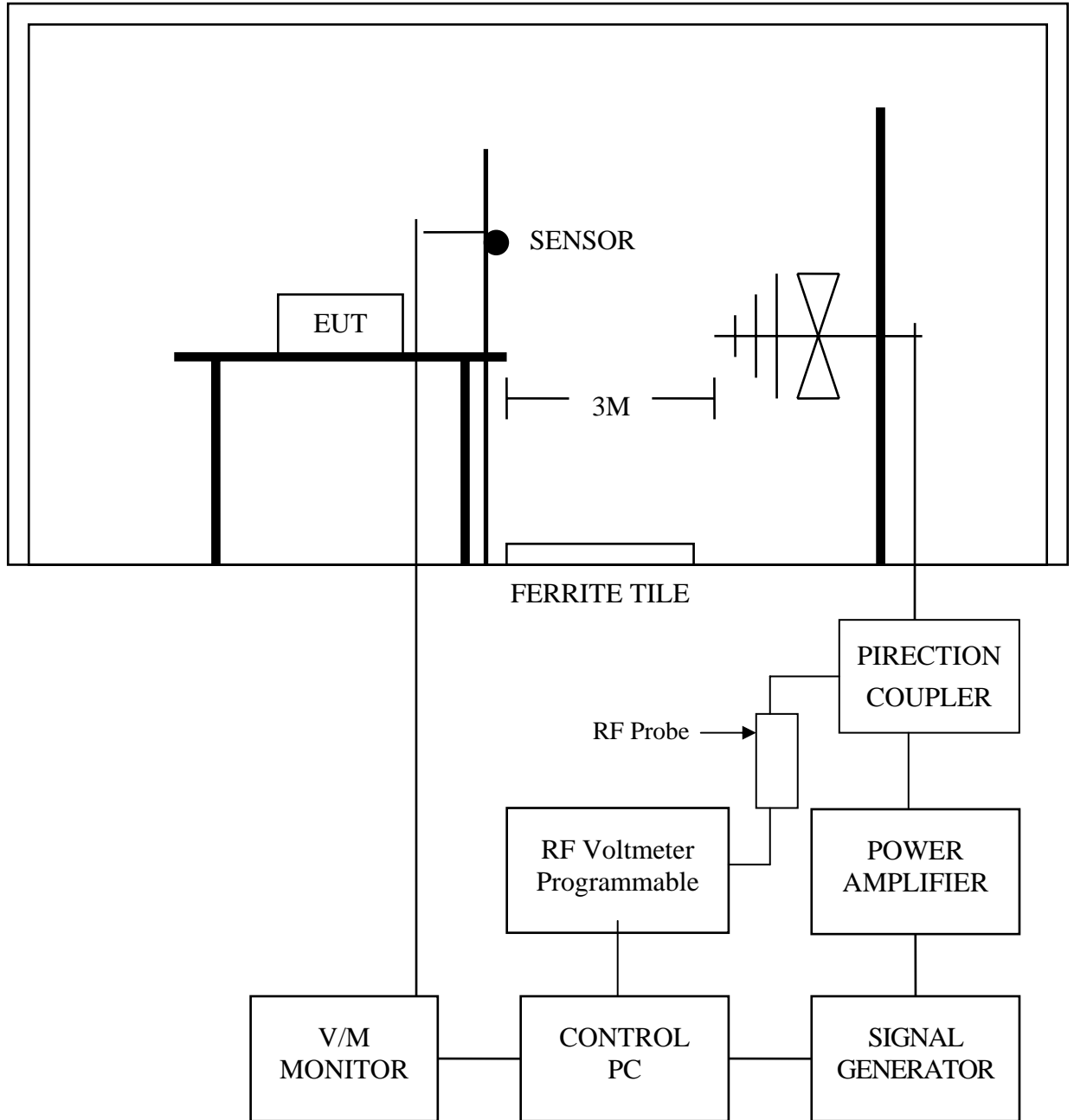
2 TEST PROCEDURE

According to **IEC 61000-4-3 (2002)**

According to **EN 55024 (1998) + A1 (2001) + A2 (2003)**

3 TEST SETUP

FERRITE TILE



3.1 Chamber Size :

12M x 5M x 5M

(Details for setup configuration, please refer to appendix A.)

4 CONFIGURATION OF THE EUT

Same as “Conducted Power Line test”, section 4

5 OPERATION CONDITION OF EUT

Same as “Conducted Power Line test”, section 5

6 TEST CONDITION

6.1 Frequency Range : 80 MHz ~ 1000 MHz

(Frequency Range : 1.4 GHz ~ 2.0 GHz is not applicable for EN55024:1998+A1:2001+A2:2003)

6.2 Filed Strength : 3 V / M (1KHz 80% Modulation)

6.3 Frequency Step : 1 %, 3 sec. / each step size

6.4 Antenna Polarity : HORIZONTAL & VERTICAL

6.5 The four sides of EUT are tested
(FRONT, REAR, RIGHT, LEFT)

6.6 Temperature : 30 °C

6.7 Humidity : 53 % RH

7 PERFORMANCE CRITERIA

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

8 TEST RESULT

ANT SIDE	HORIZONTAL	VERTICAL	RESULT
FRONT	A	A	PASSED
REAR	A	A	PASSED
RIGHT	A	A	PASSED
LEFT	A	A	PASSED

9 Photos of test configuration please refer to appendix A.

ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST (EFT)

1 TEST INSTRUMENTS & FACILITIES

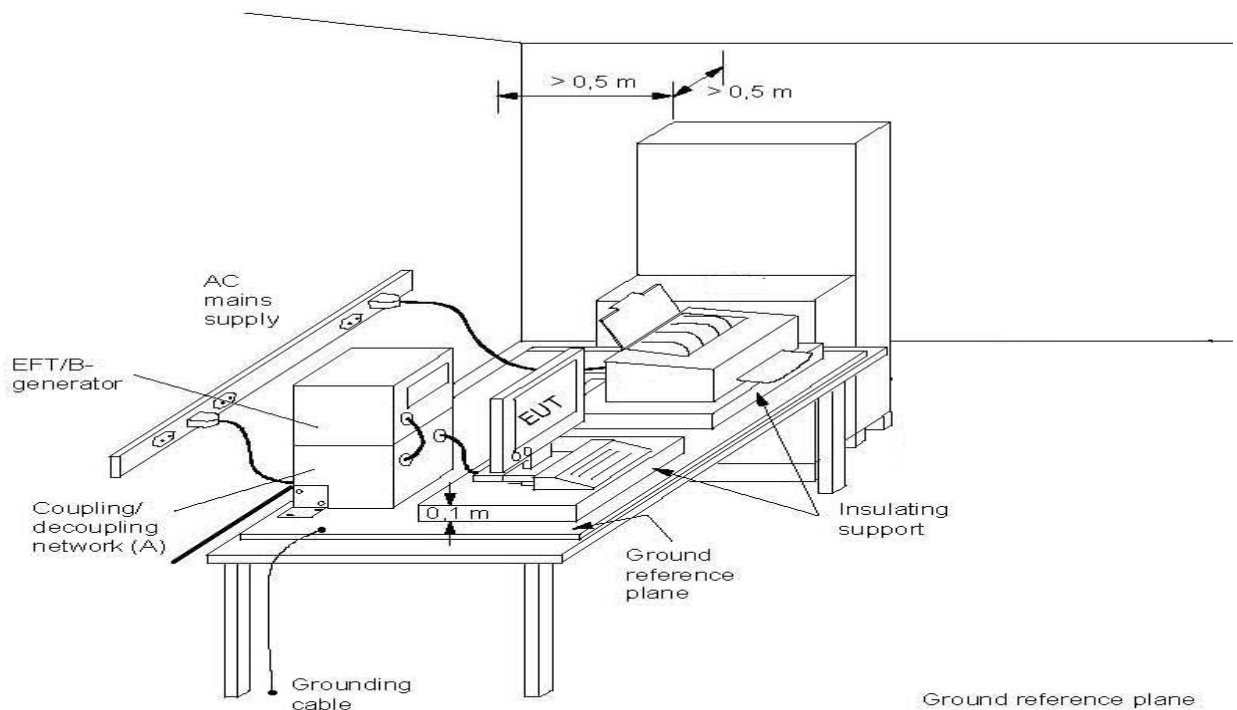
Instruments/ Facilities	Manufacturer	Model # Serial #	Data Of Cal.
BURST-TESTER	HAEFELY	PEFT/JUNIOR	FEB/2007
CONTROL PC	KB TECH	KB P586/133	--

2 TEST PROCEDURE

According to **IEC 61000-4-4 (2004)**

According to **EN 55024 (1998) + A1 (2001) + A2 (2003)**

3 TEST SETUP



(Details for setup configuration, please refer to appendix A.)

Note: length between clamp and the EUT to be tested (should be $0.5 \text{ m} \pm 0.05 \text{ m}$)

(A) location for supply line coupling

(B) location for signal line coupling

4 CONFIGURATION OF THE EUT

Same as “Conducted Power Line test”, section 4

5 OPERATION CONDITION OF EUT

Same as “Conducted Power Line test”, section 5

6 TEST CONDITION

6.1 Pulse Rise time & Duration : 5 nS / 50 nS

6.2 Pulse Repetition : 5 kHz

6.3 Polarity : POSITIVE / NEGATIVE

6.4 Test Voltage : $\pm 0.5\text{KV}$, $\pm 1\text{KV}$

6.5 Coupling of power line :

L, N, L+N

6.6 Temperature : 30 °C

6.7 Humidity : 53 % RH

7 PERFORMANCE CRITERIA

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

8 TEST RESULT

TEST VOLTAGE	L	N	L+N
$\pm 0.5\text{KV}$	A	A	A
$\pm 1\text{KV}$	A	A	A

8.1 Model : CD816AVP

8.2 Final Result : PASSED

8.3 Remark :

9 Photos of test configuration please refer to appendix A.

SURGE IMMUNITY TEST

1 TEST INSTRUMENTS & FACILITIES

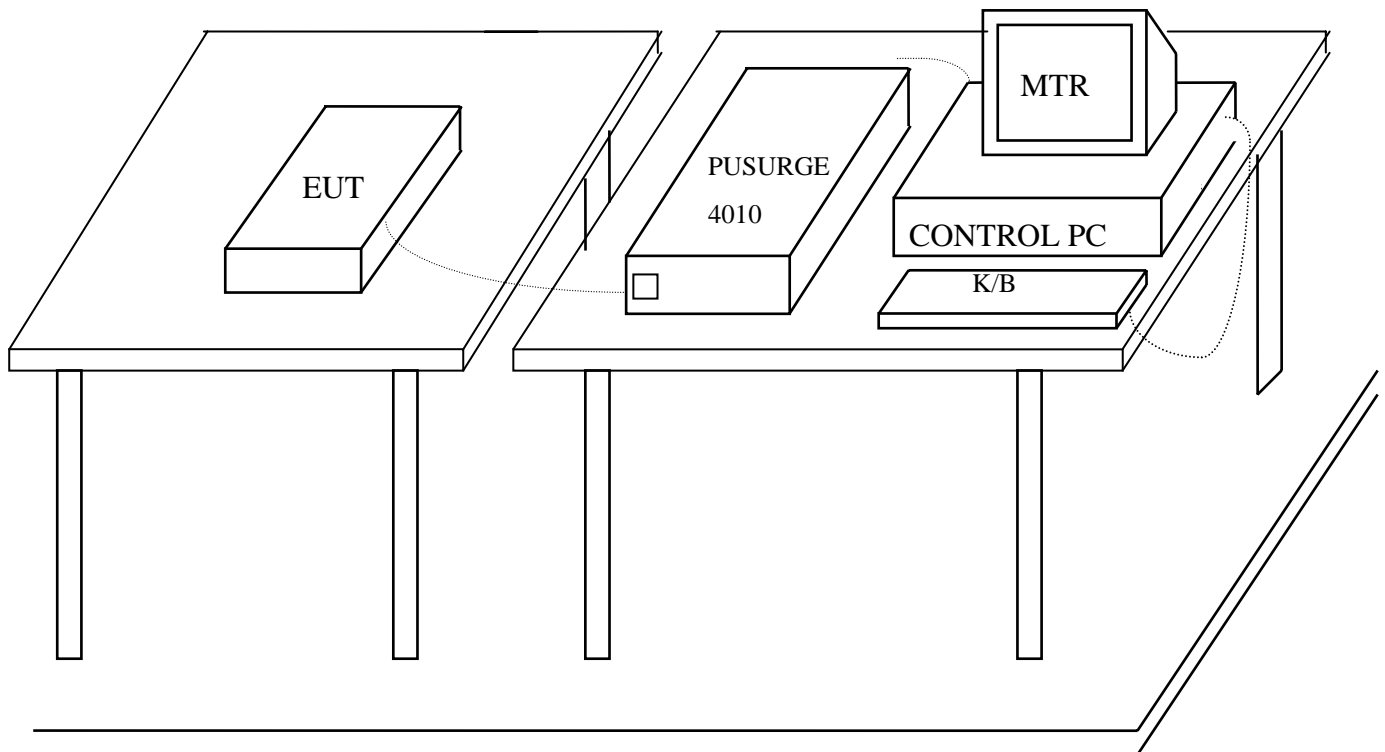
Instruments/ Facilities	Manufacturer	Model # Serial #	Data Of Cal.
SURGER-TESTER	HAEFELY	PSURGE 4010 583334-38	FEB/2007
CONTROL PC	KB TECH	KB P586/133	--

2 TEST PROCEDURE

According To **IEC 61000-4-5 (2001)**

According To **EN 55024 (1998) + A1 (2001) + A2 (2003)**

3 TEST SETUP



GROUND PLANE
(Details for setup configuration, please refer to appendix A.)

4 TEST LEVELS

- Input and Output AC Power Ports.
- DC Input and DC Output Power Ports.

Environmental Phenomena	Test Specification		Units	Performance Criteria
	AC	DC		
Surges	1.2 / 50 (8/20)		Tr /Th us	
Line to Line	±1	±0.5	KV (Charge Voltage)	B

5 CONFIGURATION OF THE EUT

Same as “Conducted Power Line test”, section 4

6 EUT OPERATION CONDITION

Same as “Conducted Power Line test”, section 5

7 CONDITIONS DURING TESTING

7.1 Coupling of power line :

(A) Line to Line ±1KV (AC) or ±0.5KV (DC)

7.2 Polarity : POSITIVE / NEGATIVE

7.3 Phase shifting in a range between 0° to 360°

7.4 Repletion rate at least 1 per min

7.5 Temperature : 30 °C (15°C ~ 35°C)

Humidity : 53 % RH.(10 % ~ 75%)

8 PERFORMANCE CRITERIA

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

9 TEST RESULT

Environmental Phenomena	Test Specification	Units	Performance
Line to Line	± 1	KV (Charge Voltage)	A

9.1 Model : CD816AVP

9.2 Final Result : PASSED

9.3 Remark :

10 Photos of test configuration please refer to appendix A.

IMMUNITY TEST TO CS CONDUCTED DISTURBANCE

1 TEST INSTRUMENTS & FACILITIES

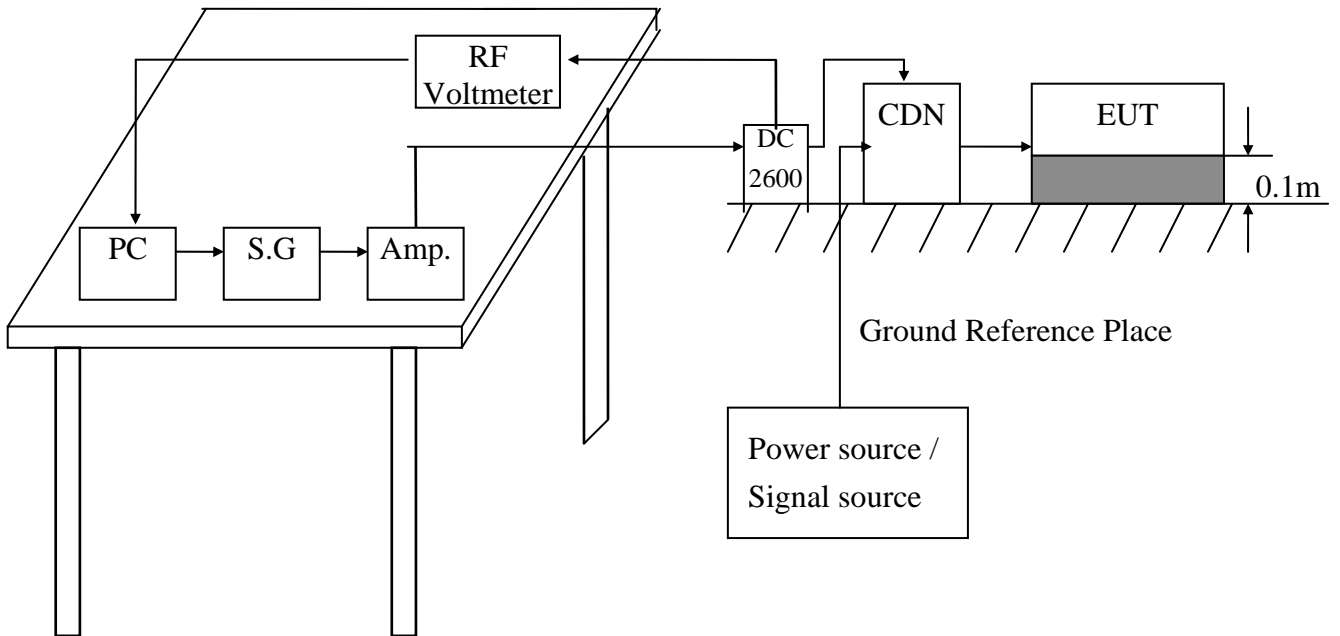
Instruments/ Facilities	Manufacturer	Model # Serial #	Date Of Cal.
SIGNAL GENERATOR	ROHDE & SCHWARZ	SMY02 845181/025	MAR/2007
AMPLIFIER	AMPLIFIER RESEARCH	75A250 25680	N/A
RF VOLTMETER	BOONTON	9200C 361701AA	MAR/2007
RF PROBE	BOONTON	952001B 37082	MAR/2007
DIRECTION COUPLER	AMPLIFIER RESEARCH	DC2600 20508	N/A
COUPLING DECOUPLING NETWORK	FCC	FCC-801-M3-25A 9993	FEB/2007
CONTROL PC	KB TECH	KB P586/133	--

2 TEST PROCEDURE

According To **IEC 61000-4-6 (2003) + A1 (2004)**

According To **EN 55024 (1998) + A1 (2001) + A2 (2003)**

3 TEST SETUP



(Details for setup configuration, please refer to appendix A.)

4 TEST LEVELS

- Ports for signal lines and control lines.
- DC input and DC output power ports.
- Input and Output AC Power Ports.
- Functional earth Ports.

Environmental	Test Specification	Units	Performance
Radio-frequency	0.15 - 80	MHz	
Common mode	3	V	A
	80	% AM (1KHz)	

5 CONFIGURATION OF THE EUT

Same as “Conducted Power Line test”, section 4

6 EUT OPERATION CONDITION

Same as “Conducted Power Line test”, section 5

7 CONDITIONS DURING TESTING

7.1 The EUT tested type :

- Single unit
- Multiple unit

7.2 Dwell time : < 1%

7.3 Temperature : 30 °C (15°C ~ 35°C)

Humidity : 53 % RH.(10 % ~ 75%)

8 PERFORMANCE CRITERIA

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

9 TEST RESULT

TEST Specification	Unit	Performance Criteria
0.15 - 80	MHz	A
3	V	
80	% AM (1KHz)	

9.1 Model : CD816AVP

9.2 Final Result : PASSED

9.3 Remark :

10 Photos of test configuration please refer to appendix A.

POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST

1 TEST INSTRUMENTS & FACILITIES

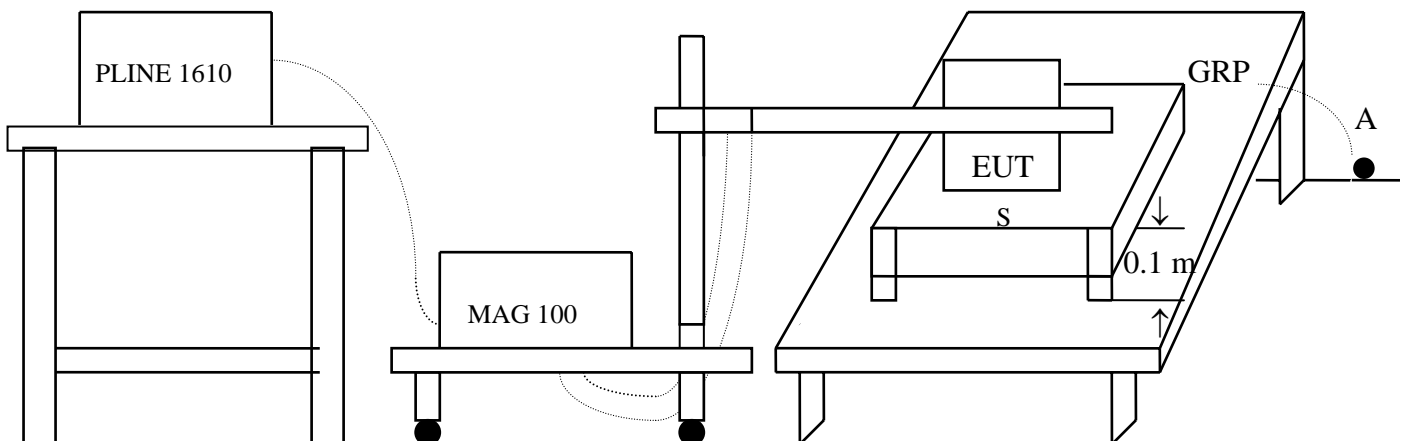
Instruments/ Facilities	Manufacturer	Model # Serial #	Data Of Cal.
LINE INTERFERENCE TESTER	HAEFELY	PLINE 1610 080166-10	FEB/2007
MAGNETIC FIELD TESTER	HAEFELY	MAG 100.1 080206-01	N/A
TRIAXIAL ELF MAGNETIC FIELD METER	F.W.BELL	4080 9645	AUG/2006
CONTROL PC	KB TECH	KB P586/133	--

2 TEST STANDARD

According To **IEC 61000-4-8 (2001)**

According To **EN 55024 (1998) + A1 (2001) + A2 (2003)**

3 TEST SETUP



S: Insulating support

A: Safety earth

GRP: Ground plane

(Details for setup configuration, please refer to appendix A.)

4 TEST LEVELS

Environmental Phenomena	Test Specification	Units	Performance Criteria
Power Frequency	50	HZ	
Magnetic Field	1	A/m	B

5 CONFIGURATION OF THE EUT

Same as “Conducted Power Line test”, section 4

6 OPERATION CONDITION OF EUT

Same as “Conducted Power Line test”, section 5

7 CONDITIONS DURING TESTING

7.1 Temperature : 30 °C (15°C ~ 35°C)

Humidity : 53 % RH.(25 % ~ 75%)

7.2 The induction coil shall be rotated by 90°

8 PERFORMANCE CRITERIA

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

9 TEST RESULTS

Environmental Phenomena	Test Specification	Units	Performance Criteria
Magnetic Field	1	A/m	A

9.1 Model : CD816AVP

9.2 Final Results : PASSED

9.3 Remark :

10 Photos of test configuration please refer to appendix A.

VOLTAGE DIPS, SHORT INTERRUPTIONS IMMUNITY TEST

1 TEST INSTRUMENTS & FACILITIES

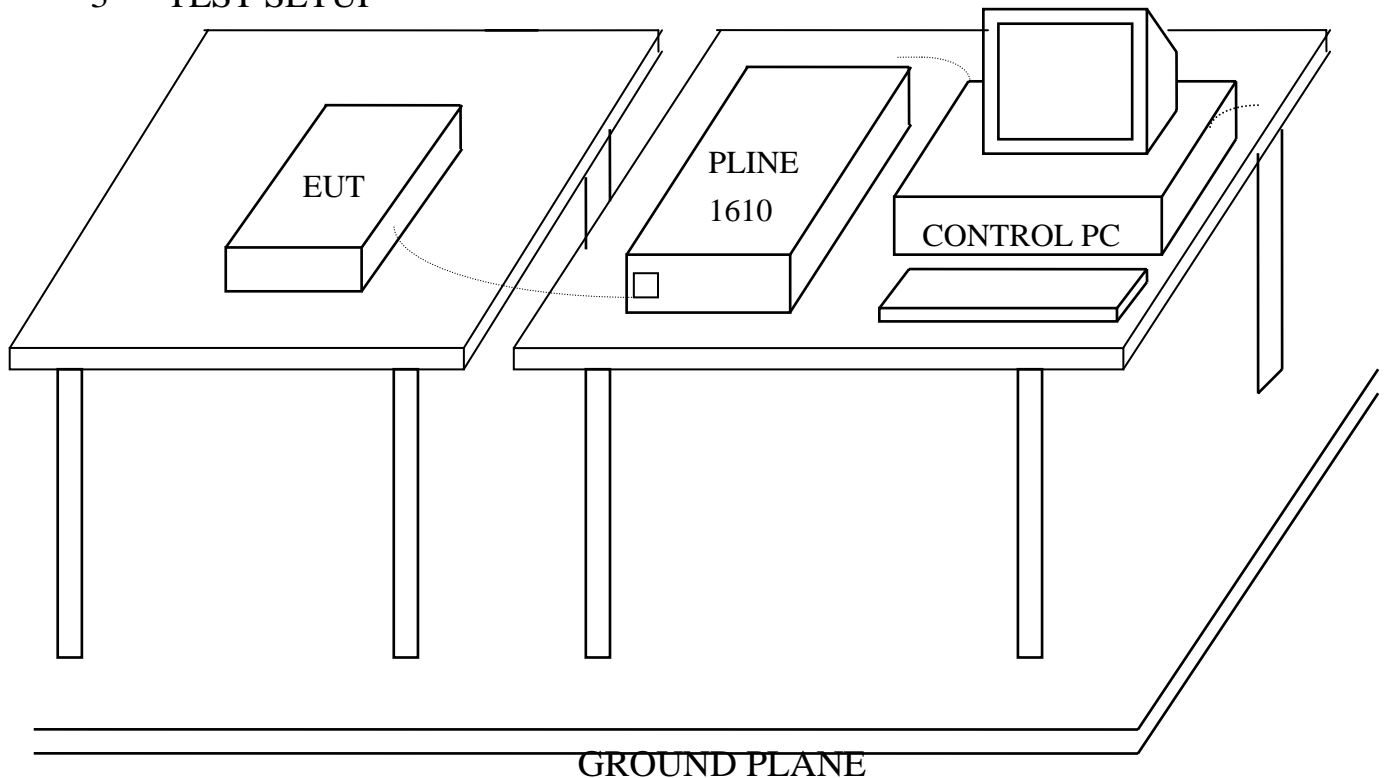
Instruments/ Facilities	Manufacturer	Model # Serial #	Data Of Cal.
LINE INTERFERENCE -TESTER	HAEFELY	PLINE 1610 080166-10	FEB/2007
CONTROL PC	KB TECH	KB P586/133	--

2 TEST PROCEDURE

According To **IEC 61000-4-11 (2004)**

According To **EN 55024 (1998) + A1 (2001) + A2 (2003)**

3 TEST SETUP



(Details for setup configuration, please refer to appendix A.)

4 TEST LEVELS

Input and Output AC Power Ports.

- Voltage Dips.
- Voltage Interruptions.

Class ^a	Test level and durations for voltage dips				
Class 1	Case-by-case according to the equipment requirements				
Class 2	0 % during 1/2 cycle	0 % during 1 cycle	70 % during 25/30 ^c cycles		
Class 3	0 % during 1/2 cycle	0 % during 1 cycle	40 % during 10/12 ^c cycles	70 % during 25/30 ^c cycles	80 % during 250/300 ^c cycles
a: Classes as per IEC 61000-2-4. b: To be defined by product committee. For equipment connected directly or indirectly to the public network, the levels must not be less severe than Class 2. c: “25/30 cycles” means “25 cycles for 50 Hz test” and “30 cycles for 60 Hz tet”.					

Class ^a	Test level and durations for short interruptions (t _s) (50Hz / 60Hz)
Class 1	Case-by-case according to the equipment requirements
Class 2	0 % during 250/300 ^c cycles
Class 3	0 % during 250/300 ^c cycles
Class X ^b	X
a: Classes as per IEC 61000-2-4. b: To be defined by product committee. For equipment connected directly or indirectly to the public network, the levels must not be less severe than Class 2. c: “250/300 cycles” means “250 cycles for 50 Hz test” and “300 cycles for 60 Hz test”.	

✘ **According to the specification of EUT, Class 2 is applied.**

5 CONFIGURATION OF THE EUT

Same as “Conducted Power Line test”, section 4

6 EUT OPERATION CONDITION

Same as “Conducted Power Line test”, section 5

7 CONDITIONS DURING TESTING

7.1 Temperature : 30 °C (15°C ~ 35°C)

Humidity : 53 % RH.(25 % ~ 75%)

8 PERFORMANCE CRITERIA

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

9 TEST RESULT

Environmental Phenomena	Test Specification	Units	Perform Criteria
Voltage Dips	0 1/2	% during Cycle	A
	0 1	% during Cycle	C
	70 25	% during Cycles	C
Voltage Short Interruptions	0 250	% during Cycles	C

9.1 Model : CD816AVP

9.2 Final Results : PASSED

9.3 Remark :

10 Photos of test configuration please refer to appendix A.



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Appendix A

PHOTOS OF TEST CONFIGURATION

PHOTO OF CONDUCTED POWER LINE TEST

Model : CD816AVP



Front View



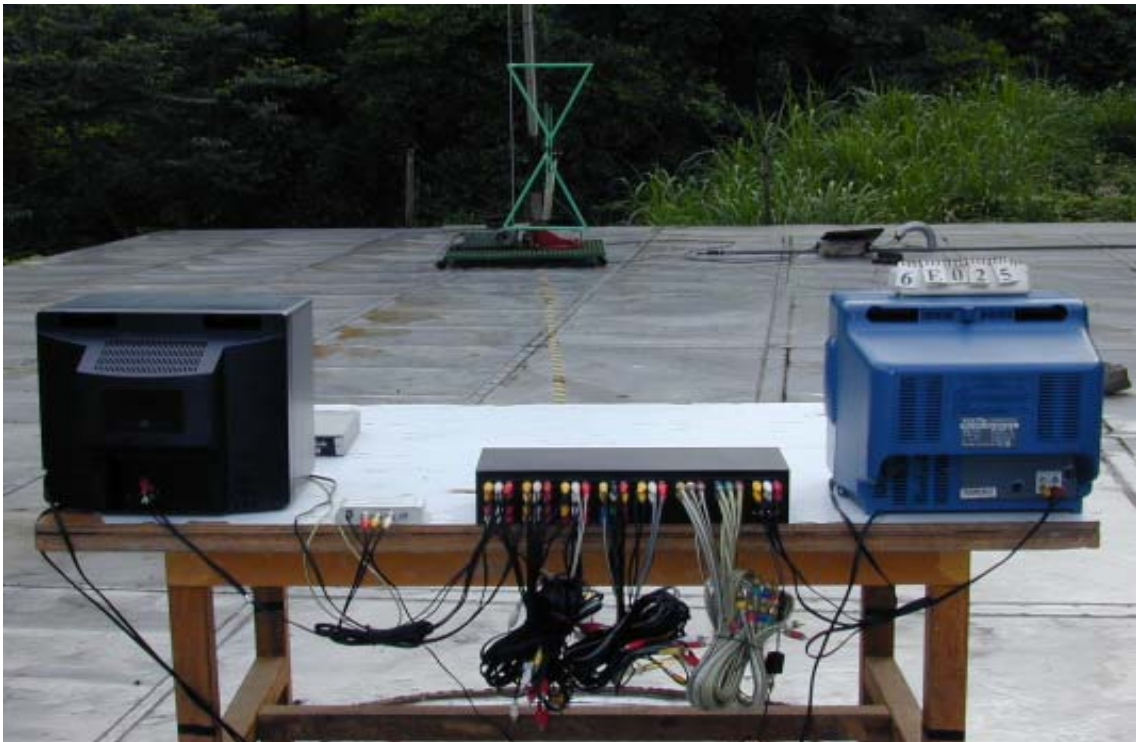
Rear View

PHOTO OF RADIATED EMISSION TEST

Model : CD816AVP



Front View



Rear View

**PHOTO OF HARMONICS & VOLTAGE FLUCTUATIONS TEST
AND SURGE IMMUNITY TEST AND VOLTAGE DIPS, SHORT
INTERRUPTIONS IMMUNITY TEST**

Model : CD816AVP



**PHOTO OF ELECTRICAL FAST TRANSIENT/BURST IMMUNITY
TEST**



PHOTO OF ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

Model : CD816AVP



PHOTO OF POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST



PHOTO OF RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

Model : CD816AVP



PHOTO OF CS CONDUCTED DISTURBANCE IMMUNITY TEST





HomeTek Technology Inc.

Appendix B

PHOTOS OF EUT

PHOTO OF EUT

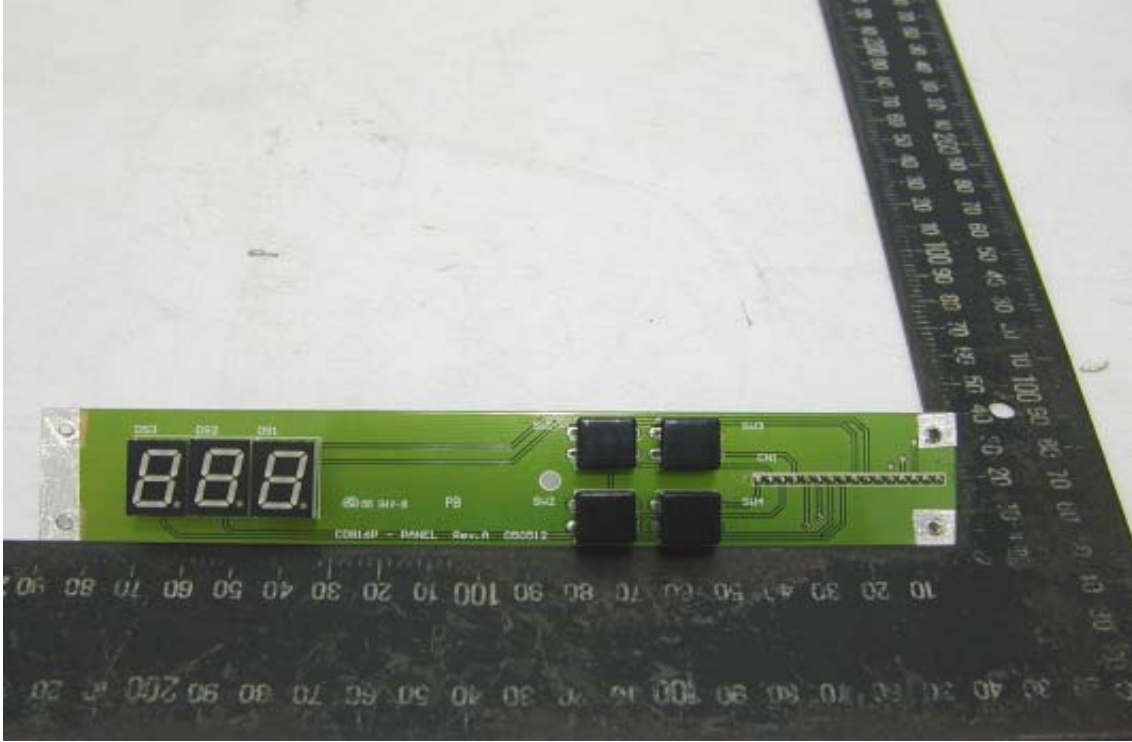
Model : CD816XXX



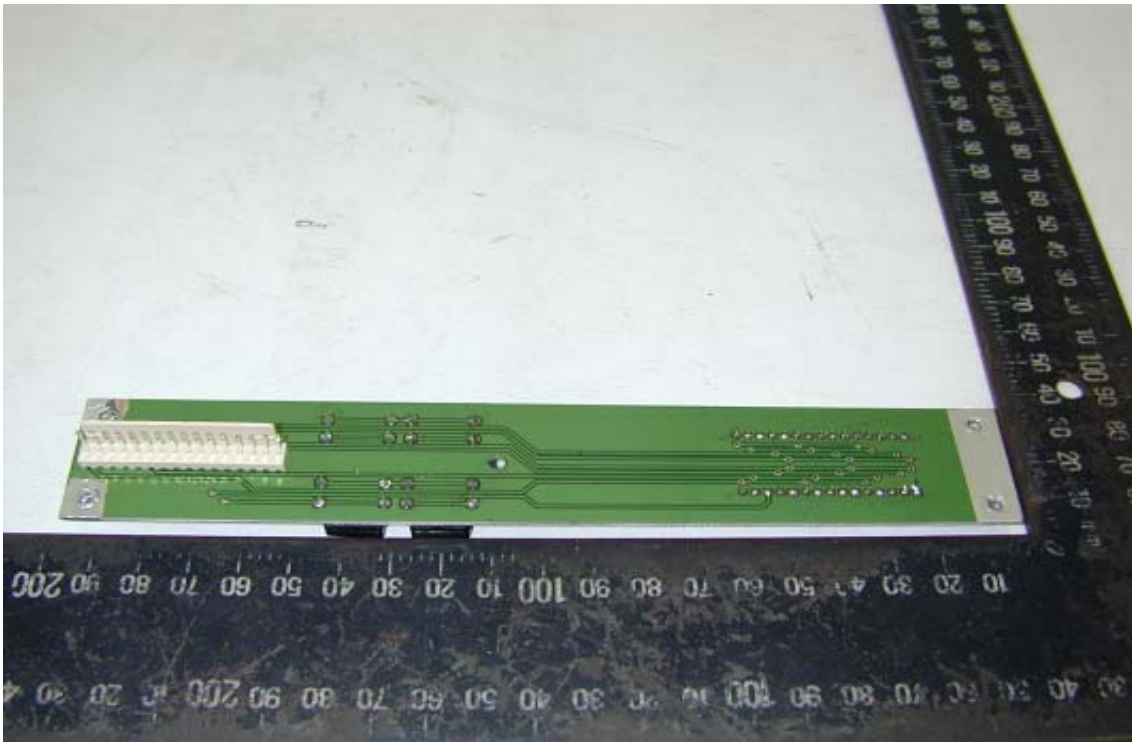
Full View of EUT

PHOTO OF EUT

Model : CD816XXX



Component Side of Main Board 1



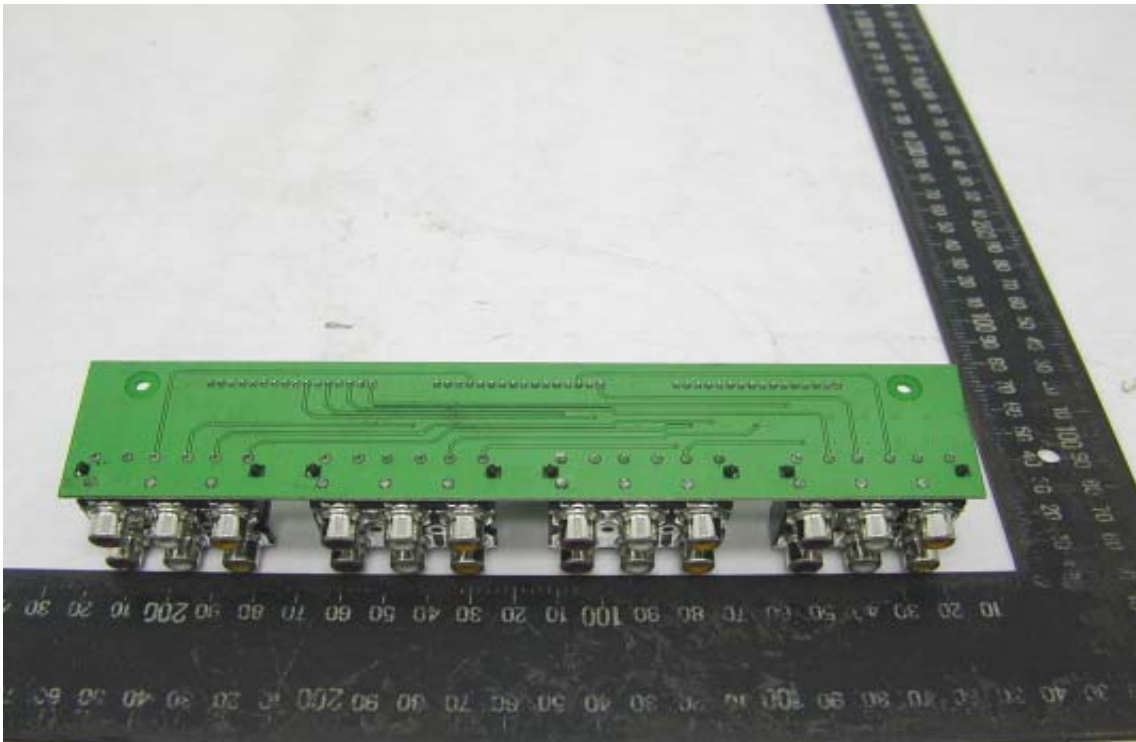
Solder Side of Main Board 1

PHOTO OF EUT

Model : CD816XXX



Component Side of Main Board 2



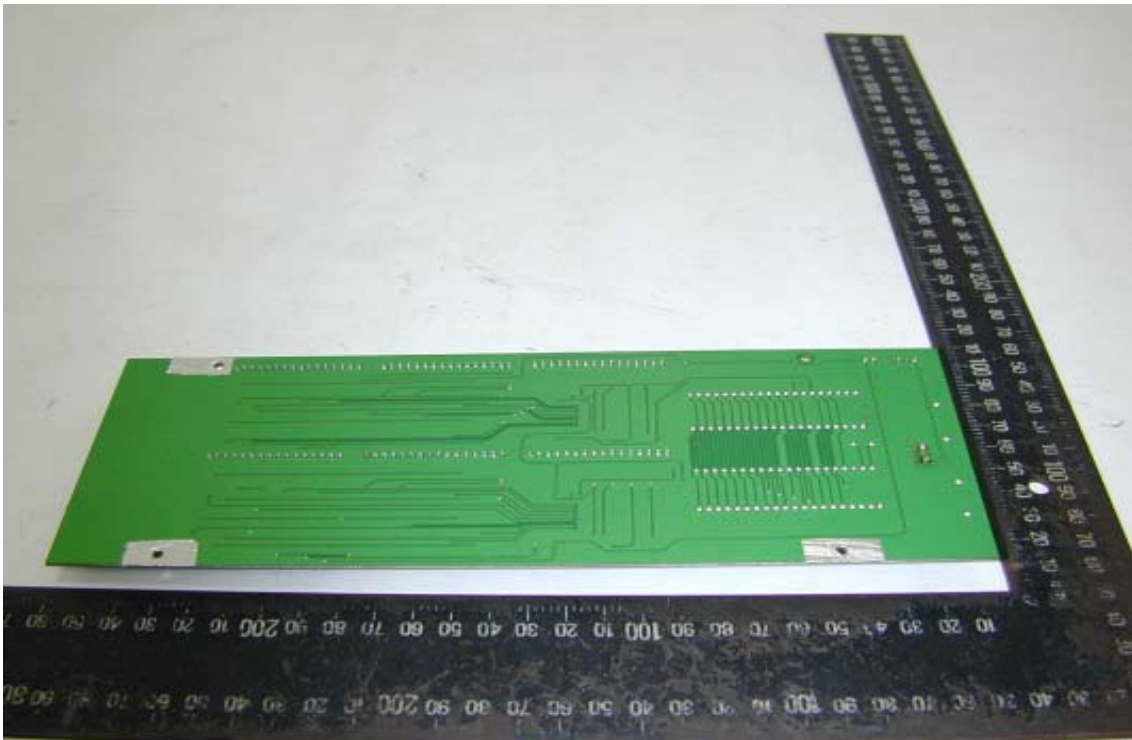
Solder Side of Main Board 2

PHOTO OF EUT

Model : CD816XXX



Component Side of Main Board 3



Solder Side of Main Board 3

PHOTO OF EUT



Front View of Adapter (Model: ADP121000N-2)



Rear View of Adapter (Model: ADP121000N-2)

Declaration of Conformity

We(Manufacturer/Importer)

(company name)

(address)

declares under our sole responsibility that the product

Product name: Programmable 8 input to 16 Output AV Distributor

Model No. : CD816XXX

to which this declaration relates is in conformity with the following standard(s) or other normative document(s)

- | | |
|---|---|
| <input checked="" type="checkbox"/> EN 55022 Class B (1998) | <input checked="" type="checkbox"/> EN 55024 (1998) |
| + A1 (2000) | + A1 (2001) |
| + A2 (2003) | + A2 (2003) |
| <input checked="" type="checkbox"/> EN 61000-3-2 (2000) | <input checked="" type="checkbox"/> IEC 61000-4-2 (2001) |
| <input checked="" type="checkbox"/> EN 61000-3-3 (1995) | <input checked="" type="checkbox"/> IEC 61000-4-3 (2002) |
| + A1 (2001) | <input checked="" type="checkbox"/> IEC 61000-4-4 (2004) |
| | <input checked="" type="checkbox"/> IEC 61000-4-5 (2001) |
| | <input checked="" type="checkbox"/> IEC 61000-4-6 (2003) |
| | + A1 (2004) |
| | <input checked="" type="checkbox"/> IEC 61000-4-8 (2001) |
| | <input checked="" type="checkbox"/> IEC 61000-4-11 (2004) |

following the provisions of 2004/108/EC Directive

Place: _____ Signature: _____

Date : _____ Full name: _____



Title: _____



TÜV Rheinland Taiwan Ltd.

Certificate

of

Appointment

for the applicant:

Hometek Technology Inc.
No. 67-9, Shir Men Rd., Tu-Cheng City,
Taipei Hsien 236, Taiwan, R.O.C.

has been authorized to carry out EMC tests by order and under supervision of TÜV Rheinland. It has successfully demonstrated capability to conduct measurement and to process test data according to:

**European and International EMC Standards as listed in the
Scope of Authorization on the attachment to this certificate**

An assessment of the facility was conducted by TÜV Rheinland auditors according to the TÜV Rheinland requirements for "Test Site Approval" with reference to


ISO 17 025:1999

Certificate No. : 10012161-2006

Valid until : June 14, 2007

TÜV Rheinland Taiwan Ltd.
Taipei, April 13, 2006


Dipl.-Ing. Andreas Klinker
Certification Body


Dipl.-Ing. Bodo Kretzschmar
Product Safety and Quality



Attachment to
Certificate
of Appointment

SCOPE OF AUTHORIZATION

Hometek Technology Inc.
No. 67-9, Shir Men Rd., Tu-Cheng City,
Taipei Hsien 236, Taiwan, R.O.C.

European Standards

EN 50081-1	EN 61000-3-2	ENV 50140
EN 50081-2	EN 61000-3-3	ENV 50141
EN 50082-1	EN 61000-6-1	ENV 50204
EN 50130-4	EN 61000-6-2	
EN 50091-2	EN 61000-6-3	
EN 55011	EN 61000-6-4	
EN 55013	EN 61000-3-11	
EN 55014-1	EN 61000-4-2	
EN 55014-2	EN 61000-4-3	
EN 55022	EN 61000-4-4	
EN 55024	EN 61000-4-5	
EN 60601-1-2	EN 61000-4-6	
EN 60801	EN 61000-4-8	
EN 60945	EN 61000-4-11	
	EN 61204-3	

International Standards

CISPR 11	IEC 61000-4-2	IEC 61000-3-2
CISPR 13	IEC 61000-4-3	IEC 61000-3-3
CISPR 14-1	IEC 61000-4-4	IEC 61000-3-11
CISPR 14-2	IEC 61000-4-5	IEC 61000-6-1
CISPR 22	IEC 61000-4-6	IEC 61000-6-2
CISPR 24	IEC 61000-4-8	IEC 61000-6-3
	IEC 61000-4-11	IEC 61000-6-4
IEC 801.2	IEC 61000-4-12	IEC 60945
IEC 801.3		
IEC 801.4		

Certificate No. : 10012161-2006

Taipei, April 13, 2006


Dipl.-Ing. Bodo Kretzschmar
Product Safety and Quality